

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SRIVASTAVA ET AL.	
		Examiner Tuan A. Vu	Art Unit 2193	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,314,558	11-2001	Angel et al.	717/118
*	B	US-6,412,106	06-2002	Leask et al.	717/124
*	C	US-5,848,274	12-1998	Hamby et al.	717/153
*	D	US-5,933,640	08-1999	Dion, Jeremy	717/132
*	E	US-6,330,692	12-2001	Kamuro et al.	714/38
*	F	US-6,385,741	05-2002	Nakamura, Mitsuhiro	714/38
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Srivastava et al., "Effectively Prioritizing Tests in Development Environment", February 2002, MSR-TR-2002-15, Publisher: Association for Computing Machinery, Inc., pp. 1-10
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.